

**Search Notes****Application/Control No.**

09/601,591

**Examiner**

Michael W. Hoye

**Applicant(s)/Patent under Reexamination**

MERIC ET AL.

**Art Unit**

2623

**SEARCHED**

Class	Subclass	Date	Examiner
725	31, 131-132, 139, 140, 151-152	9/21/2004	JM
380	28, 255	9/29/2004	JM
380	240-242	9/29/2004	JM
725	25, 31	11/4/2005	JM
Updated	Search	11/4/2005	JM
Updated	Search	5/24/2006	JM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted: Chris Nalevanko - Class 725 IEEE Search	9/27/2004	JM
Consulted: Chris Grant - Class 725	9/29/2004	JM
EAST Search	9/30/2004	JM
EAST Search	11/4/2005	JM
EAST Search	5/25/2006	JM